



Welcome to E-XFL.COM

What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "<u>Embedded -</u> <u>Microcontrollers</u>"

Details

Product Status	Active
Core Processor	S08
Core Size	8-Bit
Speed	40MHz
Connectivity	I ² C, SCI, SPI
Peripherals	LVD, POR, PWM, WDT
Number of I/O	22
Program Memory Size	60KB (60K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	2K x 8
Voltage - Supply (Vcc/Vdd)	2.7V ~ 5.5V
Data Converters	A/D 6x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	32-LQFP
Supplier Device Package	32-LQFP (7x7)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mc9s08ac60cfje

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong



Chapter 1 Introduction

	MC9S08AC60/48/32							
Feature	64-pin	48-pin	44-pin	32-pin				
SCI2		yes n						
SPI1		yes						
TPM1	6-ch	4-ch 2-ch						
TPM1CLK ¹	yes	no						
TPM2		2-ch						
TPM2CLK ¹	yes	no						
TPM3		2-0	h					
TPMCLK ¹		ye	S					
I/O pins	54	38	34	22				

Table 1-2. MC9S08AC60 Series Peripherals Available per Package Type

¹ TPMCLK, TPM1CLK, and TPM2CLK options are configured via software using the TPMCCFG bit; out of reset, TPM1CLK, TPM2CLK, and TPMCLK are available to TPM1, TPM2, and TPM3 respectively. Reference the TPM chapter for a functional description of the TPMxCLK signal.

1.2 MCU Block Diagrams

The block diagram shows the structure of the MC9S08AC60 Series MCU.



Chapter 2 Pins and Connections

external reset circuitry unnecessary. This pin is normally connected to the standard 6-pin background debug connector so a development system can directly reset the MCU system. If desired, a manual external reset can be added by supplying a simple switch to ground (pull reset pin low to force a reset).

Whenever any reset is initiated (whether from an external signal or from an internal system), the reset pin is driven low for approximately 34 cycles of f_{Self_reset} . The reset circuitry decodes the cause of reset and records it by setting a corresponding bit in the system control reset status register (SRS).

In EMC-sensitive applications, an external RC filter is recommended on the reset pin. See Figure 2-5 for an example.

2.3.4 Background/Mode Select (BKGD/MS)

While in reset, the BKGD/MS pin functions as a mode select pin. Immediately after reset rises the pin functions as the background pin and can be used for background debug communication. While functioning as a background/mode select pin, the pin includes an internal pullup device, input hysteresis, and no output slew rate control. When the pin functions as a *background* pin, it includes a high current output driver. When the pin functions as a *mode select* pin it is input only, and therefore does not include a standard output driver.

If nothing is connected to this pin, the MCU will enter normal operating mode at the rising edge of reset. If a debug system is connected to the 6-pin standard background debug header, it can hold BKGD/MS low during the rising edge of reset which forces the MCU to active background mode.

The BKGD pin is used primarily for background debug controller (BDC) communications using a custom protocol that uses 16 clock cycles of the target MCU's BDC clock per bit time. The target MCU's BDC clock could be as fast as the bus clock rate, so there should never be any significant capacitance connected to the BKGD/MS pin that could interfere with background serial communications.

Although the BKGD pin is a pseudo open-drain pin, the background debug communication protocol provides brief, actively driven, high speedup pulses to ensure fast rise times. Small capacitances from cables and the absolute value of the internal pullup device play almost no role in determining rise and fall times on the BKGD pin.

2.3.5 ADC Reference Pins (V_{REFH}, V_{REFL})

The V_{REFH} and V_{REFL} pins are the voltage reference high and voltage reference low inputs respectively for the ADC module.

2.3.6 External Interrupt Pin (IRQ)

The IRQ pin is the input source for the IRQ interrupt and is also the input for the BIH and BIL instructions. If the IRQ function is not enabled, this pin can still be configured as the TPMCLK (see the TPM chapter).

In EMC-sensitive applications, an external RC filter is recommended on the IRQ pin. See Figure 2-5 for an example.



Chapter 4 Memory



Figure 4-1. MC9S08AC60 Series Memory Map



Chapter 4 Memory





6.6.11 Port F I/O Registers (PTFD and PTFDD)

Port F parallel I/O function is controlled by the registers listed below.



Figure 6-27. Port F Data Register (PTFD)

Table 6-26. PTFD Register Field Descriptions

Field	Description
7:0 PTFDn	Port F Data Register Bits— For port F pins that are inputs, reads return the logic level on the pin. For port F pins that are configured as outputs, reads return the last value written to this register. Writes are latched into all bits of this register. For port F pins that are configured as outputs, the logic level is driven out the corresponding MCU pin. Reset forces PTFD to all 0s, but these 0s are not driven out the corresponding pins because reset also configures all port pins as high-impedance inputs with pullups disabled.

	7	6	5	4	3	2	1	0
R W	PTFDD7	PTFDD6	PTFDD5	PTFDD4	PTFDD3	PTFDD2	PTFDD1	PTFDD0
Reset	0	0	0	0	0	0	0	0

Figure 6-28. Data Direction for Port F (PTFDD)

Table 6-27. PTFDD Register Field Descriptions

Field	Description
7:0 PTFDDn	Data Direction for Port F Bits — These read/write bits control the direction of port F pins and what is read for PTFD reads.
	 Input (output driver disabled) and reads return the pin value. Output driver enabled for port F bit n and PTFD reads return the contents of PTFDn.



Field	Description
7 V	 Two's Complement Overflow Flag — The CPU sets the overflow flag when a two's complement overflow occurs. The signed branch instructions BGT, BGE, BLE, and BLT use the overflow flag. No overflow Overflow
4 H	 Half-Carry Flag — The CPU sets the half-carry flag when a carry occurs between accumulator bits 3 and 4 during an add-without-carry (ADD) or add-with-carry (ADC) operation. The half-carry flag is required for binary-coded decimal (BCD) arithmetic operations. The DAA instruction uses the states of the H and C condition code bits to automatically add a correction value to the result from a previous ADD or ADC on BCD operands to correct the result to a valid BCD value. 0 No carry between bits 3 and 4 1 Carry between bits 3 and 4
3 	Interrupt Mask Bit — When the interrupt mask is set, all maskable CPU interrupts are disabled. CPU interrupts are enabled when the interrupt mask is cleared. When a CPU interrupt occurs, the interrupt mask is set automatically after the CPU registers are saved on the stack, but before the first instruction of the interrupt service routine is executed. Interrupts are not recognized at the instruction boundary after any instruction that clears I (CLI or TAP). This ensures that the next instruction after a CLI or TAP will always be executed without the possibility of an intervening interrupt, provided I was set. 0 Interrupts disabled
2 N	 Negative Flag — The CPU sets the negative flag when an arithmetic operation, logic operation, or data manipulation produces a negative result, setting bit 7 of the result. Simply loading or storing an 8-bit or 16-bit value causes N to be set if the most significant bit of the loaded or stored value was 1. 0 Non-negative result 1 Negative result
1 Z	 Zero Flag — The CPU sets the zero flag when an arithmetic operation, logic operation, or data manipulation produces a result of 0x00 or 0x0000. Simply loading or storing an 8-bit or 16-bit value causes Z to be set if the loaded or stored value was all 0s. 0 Non-zero result 1 Zero result
0 C	 Carry/Borrow Flag — The CPU sets the carry/borrow flag when an addition operation produces a carry out of bit 7 of the accumulator or when a subtraction operation requires a borrow. Some instructions — such as bit test and branch, shift, and rotate — also clear or set the carry/borrow flag. No carry out of bit 7 Carry out of bit 7

Table 7-1. CCR Register Field Descriptions

7.3 Addressing Modes

Addressing modes define the way the CPU accesses operands and data. In the HCS08, all memory, status and control registers, and input/output (I/O) ports share a single 64-Kbyte linear address space so a 16-bit binary address can uniquely identify any memory location. This arrangement means that the same instructions that access variables in RAM can also be used to access I/O and control registers or nonvolatile program space.

Some instructions use more than one addressing mode. For instance, move instructions use one addressing mode to specify the source operand and a second addressing mode to specify the destination address. Instructions such as BRCLR, BRSET, CBEQ, and DBNZ use one addressing mode to specify the location



Source	Operation	dress ode	Object Code	cles	Cyc-by-Cyc	Affect on CCR		
Form		Ado	-	δ	Details	V 1 1 H	INZC	
RSP	Reset Stack Pointer (Low Byte) SPL ← \$FF (High Byte Not Affected)	INH	9C	1	q	-11-		
RTI	Return from Interrupt SP ← (SP) + \$0001; Pull (CCR) SP ← (SP) + \$0001; Pull (A) SP ← (SP) + \$0001; Pull (X) SP ← (SP) + \$0001; Pull (PCH) SP ← (SP) + \$0001; Pull (PCL)	INH	80	9	սսսսաքթթթ	\$1 1\$	₽₽₽₽	
RTS	Return from Subroutine SP \leftarrow SP + \$0001; Pull (PCH) SP \leftarrow SP + \$0001; Pull (PCL)	INH	81	5	ufppp	-11-		
SBC #opr8i SBC opr8a SBC opr16a SBC oprx16,X SBC oprx8,X SBC ,X SBC oprx16,SP SBC oprx8,SP	Subtract with Carry A \leftarrow (A) – (M) – (C)	IMM DIR EXT IX2 IX1 IX SP2 SP1	A2 ii B2 dd C2 hh ll D2 ee ff E2 ff F2 9E D2 ee ff 9E E2 ff	2 3 4 3 3 5 4	pp rpp prpp prpp rpp rfp pprpp prpp	↓1 1 -	-:::	
SEC	Set Carry Bit $(C \leftarrow 1)$	INH	99	1	p	-11-	1	
SEI	Set Interrupt Mask Bit $(I \leftarrow 1)$	INH	9B	1	q	-11-	1 – – –	
STA opr8a STA opr16a STA oprx16,X STA oprx8,X STA ,X STA oprx16,SP STA oprx8,SP	Store Accumulator in Memory $M \leftarrow (A)$	DIR EXT IX2 IX1 IX SP2 SP1	B7 dd C7 hh 11 D7 ee ff E7 ff F7 9E D7 ee ff 9E E7 ff	3 4 3 2 5 4	MDD bMDD MD MDD MDD MDD MDD MDD MDD MDD	011-	- \$ \$ -	
STHX opr8a STHX opr16a STHX oprx8,SP	Store H:X (Index Reg.) (M:M + \$0001) ← (H:X)	DIR EXT SP1	35 dd 96 hh 11 9E FF ff	4 5 5	wwpp pwwpp	011-	- ↓ ↓ -	
STOP	Enable Interrupts: Stop Processing Refer to MCU Documentation I bit \leftarrow 0; Stop Processing	INH	8E	2	fp	-11-	0	
STX opr8a STX opr16a STX oprx16,X STX oprx8,X STX ,X STX oprx16,SP STX oprx8,SP	Store X (Low 8 Bits of Index Register) in Memory $M \leftarrow (X)$	DIR EXT IX2 IX1 IX SP2 SP1	BF dd CF hh 11 DF ee ff EF ff FF 9E DF ee ff 9E EF ff	3 4 3 2 5 4	bmbb bpmbb bmbb bmbb bmbb	011-	- \$ \$ -	

Table 7-2	Instruction	Set	Summarv	Sheet 7 of	9)
	monaotion	00.	Cannary		~,



Chapter 9 Analog-to-Digital Converter (S08ADC10V1)

- ¹ For more information, see Section 9.2.3, "Temperature Sensor."
- ² Selecting the internal bandgap channel requires BGBE =1 in SPMSC1 see Section 5.9.8, "System Power Management Status and Control 1 Register (SPMSC1)." For value of bandgap voltage reference see Section A.6, "DC Characteristics."

9.2.1 Alternate Clock

The ADC module is capable of performing conversions using the MCU bus clock, the bus clock divided by two, the local asynchronous clock (ADACK) within the module, or the alternate clock, ALTCLK. The alternate clock for the MC9S08AC60 Series MCU devices is the external reference clock (ICGERCLK) from the internal clock generator (ICG) module.

Because ICGERCLK is active only while an external clock source is enabled, the ICG must be configured for either FBE or FEE mode (CLKS1 = 1). ICGERCLK must run at a frequency such that the ADC conversion clock (ADCK) runs at a frequency within its specified range (f_{ADCK}) after being divided down from the ALTCLK input as determined by the ADIV bits. For example, if the ADIV bits are set up to divide by four, then the minimum frequency for ALTCLK (ICGERCLK) is four times the minimum value for f_{ADCK} and the maximum frequency is four times the maximum value for f_{ADCK} . Because of the minimum frequency requirement, when an oscillator circuit is used it must be configured for high range operation (RANGE = 1).

ALTCLK is active while the MCU is in wait mode provided the conditions described above are met. This allows ALTCLK to be used as the conversion clock source for the ADC while the MCU is in wait mode.

ALTCLK cannot be used as the ADC conversion clock source while the MCU is in stop3.

9.2.2 Hardware Trigger

The ADC hardware trigger, ADHWT, is output from the real time interrupt (RTI) counter. The RTI counter can be clocked by either ICGERCLK or a nominal 1 kHz clock source within the RTI block. The 1-kHz clock source can be used with the MCU in run, wait, or stop3. With the ICG configured for either FBE or FEE mode, ICGERCLK can be used with the MCU in run or wait.

The period of the RTI is determined by the input clock frequency and the RTIS bits. When the ADC hardware trigger is enabled, a conversion is initiated upon an RTI counter overflow. The RTI counter is a free running counter that generates an overflow at the RTI rate determined by the RTIS bits.

NOTE

An ADC trigger is generated on the first RTI overflow and every two RTI counter overflows following. This is due to the fact that the RTI counter expires and the ADC trigger is generated on RTI output rising edge.

9.2.2.1 Analog Pin Enables

The ADC on MC9S08AC60 Series contains only two analog pin enable registers, APCTL1 and APCTL2.

9.2.2.2 Low-Power Mode Operation

The ADC is capable of running in stop3 mode but requires LVDSE and LVDE in SPMSC1 to be set.



10.1.1 Features

The module is intended to be very user friendly with many of the features occurring automatically without user intervention. To quickly configure the module, go to Section 10.5, "Initialization/Application Information" and pick an example that best suits the application needs.

Features of the ICG and clock distribution system:

- Several options for the primary clock source allow a wide range of cost, frequency, and precision choices:
 - 32 kHz-100 kHz crystal or resonator
 - 1 MHz–16 MHz crystal or resonator
 - External clock
 - Internal reference generator
- Defaults to self-clocked mode to minimize startup delays
- Frequency-locked loop (FLL) generates 8 MHz to 40 MHz (for bus rates up to 20 MHz)
 Uses external or internal clock as reference frequency
- Automatic lockout of non-running clock sources
- Reset or interrupt on loss of clock or loss of FLL lock
- Digitally-controlled oscillator (DCO) preserves previous frequency settings, allowing fast frequency lock when recovering from stop3 mode
- DCO will maintain operating frequency during a loss or removal of reference clock
- Post-FLL divider selects 1 of 8 bus rate divisors (/1 through /128)
- Separate self-clocked source for real-time interrupt
- Trimmable internal clock source supports SCI communications without additional external components
- Automatic FLL engagement after lock is acquired
- External oscillator selectable for low power or high gain

10.1.2 Modes of Operation

This is a high-level description only. Detailed descriptions of operating modes are contained in Section 10.4, "Functional Description."

• Mode 1 — Off

The output clock, ICGOUT, is static. This mode may be entered when the STOP instruction is executed.

• Mode 2 — Self-clocked (SCM)

Default mode of operation that is entered immediately after reset. The ICG's FLL is open loop and the digitally controlled oscillator (DCO) is free running at a frequency set by the filter bits.

• Mode 3 — FLL engaged internal (FEI)

In this mode, the ICG's FLL is used to create frequencies that are programmable multiples of the internal reference clock.

The oscillator pins are used to provide an external clock source for the MCU. The oscillator pins are gain controlled in low-power mode (default). Oscillator amplitudes in low-power mode are limited to approximately 1 V, peak-to-peak.

10.2.1 EXTAL — External Reference Clock / Oscillator Input

If upon the first write to ICGC1, either the FEE mode or FBE mode is selected, this pin functions as either the external clock input or the input of the oscillator circuit as determined by REFS. If upon the first write to ICGC1, either the FEI mode or SCM mode is selected, this pin is not used by the ICG.

10.2.2 XTAL — Oscillator Output

If upon the first write to ICGC1, either the FEE mode or FBE mode is selected, this pin functions as the output of the oscillator circuit. If upon the first write to ICGC1, either the FEI mode or SCM mode is selected, this pin is not used by the ICG. The oscillator is capable of being configured to provide a higher amplitude output for improved noise immunity. This mode of operation is selected by HGO = 1.

10.2.3 External Clock Connections

If an external clock is used, then the pins are connected as shown Figure 10-4.





10.2.4 External Crystal/Resonator Connections

If an external crystal/resonator frequency reference is used, then the pins are connected as shown in Figure 10-5. Recommended component values are listed in the Electrical Characteristics chapter.



Internal Clock Generator (S08ICGV4)



Table 10-6. ICGFLTL Register Field Descriptions

Field	Description
7:0 FLT	Filter Value — The FLT bits indicate the current filter value, which controls the DCO frequency. The FLT bits are read only except when the CLKS bits are programmed to self-clocked mode (CLKS = 00). In self-clocked mode, any write to ICGFLTU updates the current 12-bit filter value. Writes to the ICGFLTU register will not affect FLT if a previous latch sequence is not complete. The filter registers show the filter value (FLT).

10.3.6 ICG Trim Register (ICGTRM)



U = Unaffected by MCU reset

Figure 10-12. ICG Trim Register (ICGTRM)

Table 10-7. ICGTRM Register Field Descriptions

Field	Description
7 TRIM	ICG Trim Setting — The TRIM bits control the internal reference generator frequency. They allow a ±25%
	as much as changing bit 0). Increasing the binary value in TRIM will increase the period and decreasing the value
	will decrease the period.

10.4 Functional Description

This section provides a functional description of each of the five operating modes of the ICG. Also discussed are the loss of clock and loss of lock errors and requirements for entry into each mode. The ICG is very flexible, and in some configurations, it is possible to exceed certain clock specifications. When using the FLL, configure the ICG so that the frequency of ICGDCLK does not exceed its maximum value to ensure proper MCU operation.



Internal Clock Generator (S08ICGV4)

10.4.7.1 FLL Engaged External Unlocked

FEE unlocked is entered when FEE is entered and the count error (Δn) output from the subtractor is greater than the maximum n_{unlock} or less than the minimum n_{unlock} , as required by the lock detector to detect the unlock condition.

The ICG will remain in this state while the count error (Δn) is greater than the maximum n_{lock} or less than the minimum n_{lock} , as required by the lock detector to detect the lock condition.

In this state, the pulse counter, subtractor, digital loop filter, and DCO form a closed loop and attempt to lock it according to their operational descriptions later in this section. Upon entering this state and until the FLL becomes locked, the output clock signal ICGOUT frequency is given by $f_{ICGDCLK} / (2 \times R)$ This extra divide by two prevents frequency overshoots during the initial locking process from exceeding chip-level maximum frequency specifications. After the FLL has locked, if an unexpected loss of lock causes it to re-enter the unlocked state while the ICG remains in FEE mode, the output clock signal ICGOUT frequency is given by $f_{ICGDCLK} / R$.

10.4.7.2 FLL Engaged External Locked

FEE locked is entered from FEE unlocked when the count error (Δn) is less than n_{lock} (max) and greater than n_{lock} (min) for a given number of samples, as required by the lock detector to detect the lock condition. The output clock signal ICGOUT frequency is given by $f_{ICGDCLK}/R$. In FLL engaged external locked, the filter value is updated only once every four comparison cycles. The update made is an average of the error measurements taken in the four previous comparisons.

10.4.8 FLL Lock and Loss-of-Lock Detection

To determine the FLL locked and loss-of-lock conditions, the pulse counter counts the pulses of the DCO for one comparison cycle (see Table 10-9 for explanation of a comparison cycle) and passes this number to the subtractor. The subtractor compares this value to the value in MFD and produces a count error, Δn . To achieve locked status, Δn must be between n_{lock} (min) and n_{lock} (max). After the FLL has locked, Δn must stay between n_{unlock} (min) and n_{unlock} (max) to remain locked. If Δn goes outside this range unexpectedly, the LOLS status bit is set and remains set until cleared by software or until the MCU is reset. LOLS is cleared by reading ICGS1 then writing 1 to ICGIF (LOLRE = 0), or by a loss-of-lock induced reset (LOLRE = 1), or by any MCU reset.

If the ICG enters the off state due to stop mode when ENBDM = OSCSTEN = 0, the FLL loses locked status (LOCK is cleared), but LOLS remains unchanged because this is not an unexpected loss-of-lock condition. Though it would be unusual, if ENBDM is cleared to 0 while the MCU is in stop, the ICG enters the off state. Because this is an unexpected stopping of clocks, LOLS will be set when the MCU wakes up from stop.

Expected loss of lock occurs when the MFD or CLKS bits are changed or in FEI mode only, when the TRIM bits are changed. In these cases, the LOCK bit will be cleared until the FLL regains lock, but the LOLS will not be set.



Internal Clock Generator (S08ICGV4)

Bits 11:0 FLT No need for user initialization

ICGTRM = \$xx

Bits 7:0 TRIM Only need to write when trimming internal oscillator; not used when external crystal is clock source

Figure 10-14 shows flow charts for three conditions requiring ICG initialization.







Serial Communications Interface (S08SCIV4)

13.1.3 Block Diagram

Figure 13-2 shows the transmitter portion of the SCI.



Figure 13-2. SCI Transmitter Block Diagram



Writing 0 to TE does not immediately release the pin to be a general-purpose I/O pin. Any transmit activity that is in progress must first be completed. This includes data characters in progress, queued idle characters, and queued break characters.

13.3.2.1 Send Break and Queued Idle

The SBK control bit in SCIxC2 is used to send break characters which were originally used to gain the attention of old teletype receivers. Break characters are a full character time of logic 0 (10 bit times including the start and stop bits). A longer break of 13 bit times can be enabled by setting BRK13 = 1. Normally, a program would wait for TDRE to become set to indicate the last character of a message has moved to the transmit shifter, then write 1 and then write 0 to the SBK bit. This action queues a break character to be sent as soon as the shifter is available. If SBK is still 1 when the queued break moves into the shifter (synchronized to the baud rate clock), an additional break character is queued. If the receiving device is another SCI, the break characters will be received as 0s in all eight data bits and a framing error (FE = 1) occurs.

When idle-line wakeup is used, a full character time of idle (logic 1) is needed between messages to wake up any sleeping receivers. Normally, a program would wait for TDRE to become set to indicate the last character of a message has moved to the transmit shifter, then write 0 and then write 1 to the TE bit. This action queues an idle character to be sent as soon as the shifter is available. As long as the character in the shifter does not finish while TE = 0, the SCI transmitter never actually releases control of the TxD pin. If there is a possibility of the shifter finishing while TE = 0, set the general-purpose I/O controls so the pin that is shared with TxD is an output driving a logic 1. This ensures that the TxD line will look like a normal idle line even if the SCI loses control of the port pin between writing 0 and then 1 to TE.

The length of the break character is affected by the BRK13 and M bits as shown below.

BRK13	М	Break Character Length
0	0	10 bit times
0	1	11 bit times
1	0	13 bit times
1	1	14 bit times

Table 13-8. Break Character Length

13.3.3 Receiver Functional Description

In this section, the receiver block diagram (Figure 13-3) is used as a guide for the overall receiver functional description. Next, the data sampling technique used to reconstruct receiver data is described in more detail. Finally, two variations of the receiver wakeup function are explained.

The receiver input is inverted by setting RXINV = 1. The receiver is enabled by setting the RE bit in SCIxC2. Character frames consist of a start bit of logic 0, eight (or nine) data bits (LSB first), and a stop bit of logic 1. For information about 9-bit data mode, refer to Section 13.3.5.1, "8- and 9-Bit Data Modes." For the remainder of this discussion, we assume the SCI is configured for normal 8-bit data mode.

After receiving the stop bit into the receive shifter, and provided the receive data register is not already full, the data character is transferred to the receive data register and the receive data register full (RDRF)





14.2 External Signal Description

The SPI optionally shares four port pins. The function of these pins depends on the settings of SPI control bits. When the SPI is disabled (SPE = 0), these four pins revert to being general-purpose port I/O pins that are not controlled by the SPI.

14.2.1 SPSCK — SPI Serial Clock

When the SPI is enabled as a slave, this pin is the serial clock input. When the SPI is enabled as a master, this pin is the serial clock output.

14.2.2 MOSI — Master Data Out, Slave Data In

When the SPI is enabled as a master and SPI pin control zero (SPC0) is 0 (not bidirectional mode), this pin is the serial data output. When the SPI is enabled as a slave and SPC0 = 0, this pin is the serial data input. If SPC0 = 1 to select single-wire bidirectional mode, and master mode is selected, this pin becomes the bidirectional data I/O pin (MOMI). Also, the bidirectional mode output enable bit determines whether the pin acts as an input (BIDIROE = 0) or an output (BIDIROE = 1). If SPC0 = 1 and slave mode is selected, this pin is not used by the SPI and reverts to being a general-purpose port I/O pin.

14.2.3 MISO — Master Data In, Slave Data Out

When the SPI is enabled as a master and SPI pin control zero (SPC0) is 0 (not bidirectional mode), this pin is the serial data input. When the SPI is enabled as a slave and SPC0 = 0, this pin is the serial data output. If SPC0 = 1 to select single-wire bidirectional mode, and slave mode is selected, this pin becomes the bidirectional data I/O pin (SISO) and the bidirectional mode output enable bit determines whether the pin acts as an input (BIDIROE = 0) or an output (BIDIROE = 1). If SPC0 = 1 and master mode is selected, this pin is not used by the SPI and reverts to being a general-purpose port I/O pin.

14.2.4 SS — Slave Select

When the SPI is enabled as a slave, this pin is the low-true slave select input. When the SPI is enabled as a master and mode fault enable is off (MODFEN = 0), this pin is not used by the SPI and reverts to being a general-purpose port I/O pin. When the SPI is enabled as a master and MODFEN = 1, the slave select output enable bit determines whether this pin acts as the mode fault input (SSOE = 0) or as the slave select output (SSOE = 1).



Figure 16-2 shows an external host transmitting a logic 1 or 0 to the BKGD pin of a target HCS08 MCU. The host is asynchronous to the target so there is a 0-to-1 cycle delay from the host-generated falling edge to where the target perceives the beginning of the bit time. Ten target BDC clock cycles later, the target senses the bit level on the BKGD pin. Typically, the host actively drives the pseudo-open-drain BKGD pin during host-to-target transmissions to speed up rising edges. Because the target does not drive the BKGD pin during the host-to-target transmission period, there is no need to treat the line as an open-drain signal during this period.



Figure 16-2. BDC Host-to-Target Serial Bit Timing



A force-type breakpoint waits for the current instruction to finish and then acts upon the breakpoint request. The usual action in response to a breakpoint is to go to active background mode rather than continuing to the next instruction in the user application program.

The tag vs. force terminology is used in two contexts within the debug module. The first context refers to breakpoint requests from the debug module to the CPU. The second refers to match signals from the comparators to the debugger control logic. When a tag-type break request is sent to the CPU, a signal is entered into the instruction queue along with the opcode so that if/when this opcode ever executes, the CPU will effectively replace the tagged opcode with a BGND opcode so the CPU goes to active background mode rather than executing the tagged instruction. When the TRGSEL control bit in the DBGT register is set to select tag-type operation, the output from comparator A or B is qualified by a block of logic in the debug module that tracks opcodes and only produces a trigger to the debugger if the opcode at the compare address is actually executed. There is separate opcode tracking logic for each comparator so more than one compare event can be tracked through the instruction queue at a time.

16.3.5 Trigger Modes

The trigger mode controls the overall behavior of a debug run. The 4-bit TRG field in the DBGT register selects one of nine trigger modes. When TRGSEL = 1 in the DBGT register, the output of the comparator must propagate through an opcode tracking circuit before triggering FIFO actions. The BEGIN bit in DBGT chooses whether the FIFO begins storing data when the qualified trigger is detected (begin trace), or the FIFO stores data in a circular fashion from the time it is armed until the qualified trigger is detected (end trigger).

A debug run is started by writing a 1 to the ARM bit in the DBGC register, which sets the ARMF flag and clears the AF and BF flags and the CNT bits in DBGS. A begin-trace debug run ends when the FIFO gets full. An end-trace run ends when the selected trigger event occurs. Any debug run can be stopped manually by writing a 0 to ARM or DBGEN in DBGC.

In all trigger modes except event-only modes, the FIFO stores change-of-flow addresses. In event-only trigger modes, the FIFO stores data in the low-order eight bits of the FIFO.

The BEGIN control bit is ignored in event-only trigger modes and all such debug runs are begin type traces. When TRGSEL = 1 to select opcode fetch triggers, it is not necessary to use R/W in comparisons because opcode tags would only apply to opcode fetches that are always read cycles. It would also be unusual to specify TRGSEL = 1 while using a full mode trigger because the opcode value is normally known at a particular address.

The following trigger mode descriptions only state the primary comparator conditions that lead to a trigger. Either comparator can usually be further qualified with R/W by setting RWAEN (RWBEN) and the corresponding RWA (RWB) value to be matched against R/W. The signal from the comparator with optional R/W qualification is used to request a CPU breakpoint if BRKEN = 1 and TAG determines whether the CPU request will be a tag request or a force request.



Appendix A Electrical Characteristics and Timing Specifications

A.6 DC Characteristics

This section includes information about power supply requirements, I/O pin characteristics, and power supply current in various operating modes.

Num	С	Parameter	Symbol	Min	Typ ¹	Max	Unit
		Output high voltage — Low Drive (PTxDSn = 0) 5 V, I _{Load} = -2 mA 3 V, I _{Load} = -0.6 mA 5 V, I _{Load} = -0.4 mA 3 V, I _{Load} = -0.24 mA	Vol	$V_{DD} - 1.5$ $V_{DD} - 1.5$ $V_{DD} - 0.8$ $V_{DD} - 0.8$			
1	Ρ	Output high voltage — High Drive (PTxDSn = 1) 5 V, I _{Load} = -10 mA 3 V, I _{Load} = -3 mA 5 V, I _{Load} = -2 mA 3 V, I _{Load} = -0.4 mA		V _{DD} - 1.5 V _{DD} - 1.5 V _{DD} - 0.8 V _{DD} - 0.8			>
		Output low voltage — Low Drive (PTxDSn = 0) 5 V, I _{Load} = 2 mA 3 V, I _{Load} = 0.6 mA 5 V, I _{Load} = 0.4 mA 3 V, I _{Load} = 0.24 mA	Vol	1.5 1.5 0.8 0.8			
2	Ρ	Output low voltage — High Drive (PTxDSn = 1) $5 \text{ V}, \text{ I}_{\text{Load}} = 10 \text{ mA}$ $3 \text{ V}, \text{ I}_{\text{Load}} = 3 \text{ mA}$ $5 \text{ V}, \text{ I}_{\text{Load}} = 2 \text{ mA}$ $3 \text{ V}, \text{ I}_{\text{Load}} = 0.4 \text{ mA}$	VOL	1.5 1.5 0.8 0.8			v
3	Ρ	Output high current — Max total I _{OH} for all ports 5V 3V	I _{OHT}			100 60	mA
4	Ρ	Output low current — Max total I _{OL} for all ports 5V 3V	I _{OLT}			100 60	mA
5	Ρ	Input high $2.7v \le V_{DD} 4.5v$	V _{IH}	0.70xV _{DD}	_	—	
		voltage; all $4.5v \le V_{DD} \le 5.5v$	V _{IH}	0.65xV _{DD}			V
6	Ρ	Input low voltage; all digital inputs	V _{IL}	_	—	0.35 x V _{DD}	
7	Ρ	Input hysteresis; all digital inputs	V _{hys}	$0.06 \times V_{DD}$			mV
8	Ρ	Input leakage current; input only pins ²	ll _{In} l		0.1	1	μA
9	Ρ	High Impedance (off-state) leakage current ²	ll _{oz} l	—	0.1	1	μA
10	Ρ	Internal pullup resistors ³	R _{PU}	20	45	65	kΩ
11	Ρ	Internal pulldown resistors ⁴	R _{PD}	20	45	65	kΩ
12	С	Input Capacitance; all non-supply pins	C _{In}	—	—	8	pF
13	D	RAM retention voltage	V _{RAM}	—	0.6	1.0	V
14	Ρ	POR rearm voltage	V _{POR}	0.9	1.4	2.0	V
15	D	POR rearm time	t _{POR}	10	—	—	μS

Table A-6. DC Characteristics



NOTES:

- 1. DIMENSIONS ARE IN MILLIMETERS.
- 2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
- 3. THE COMPLETE JEDEC DESIGNATOR FOR THIS PACKAGE IS: HF-PQFN.

4. COPLANARITY APPLIES TO LEADS, CORNER LEADS, AND DIE ATTACH PAD.

5. MIN METAL GAP SHOULD BE 0.2MM.

© FREESCALE SEMICONDUCTOR, INC. All rights reserved.	MECHANICAL OUTLINE		PRINT VERSION NOT TO SCALE	
TITLE: THERMALLY ENHANCED QUAD FLAT NON-LEADED PACKAGE (QFN) 48 TERMINAL, 0.5 PITCH (7 X 7 X 1)		DOCUMENT NO: 98ARH99048A		REV: F
		CASE NUMBER	2: 1314–05	05 DEC 2005
		STANDARD: JEDEC-MO-220 VKKD-2		